Cooper-pair resonances and subgap Coulom b blockade in a superconducting single-electron transistor

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We have fabricated and measured superconducting single-electron transistors with Alleads and Nb islands. At bias voltages below the gap of Nb we observe clear signatures of resonant tunneling of Cooper pairs, and of Coulom b blockade of the subgap currents due to linewidth broadening of the energy levels in the superconducting density of states of Nb. The experimental results are in good agreement with numerical simulations.

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The single-electron transistor¹ (SET) and its superconducting version is one of the most versatile tools in mesoscopic physics. It has been used for extremely sensitive charge measurements,² for the construction of C coper pairpumps and other adiabatic devices with applications in metrology,³ and more recently for building up superconducting quantum bits.⁴

The IV characteristics of superconducting SETs present the usual features of quasiparticle tunneling (at voltages above 2 $_{Nb}$ + 2 $_{Al}$), Josephson-quasiparticle tunneling (at half of these values), and Josephson e ect (around zero bias). These features have been thoroughly investigated by now by many groups and the physics of a charge transport at these bias voltages is well understood. However, at low bias voltages also other transport processes could become important and can alter the perform ance of Josephson-based devices. In this paper, we study two such processes appearing in our Nb-based SET: Resonant tunneling of Cooper pairs, and transport through states inside the gap of Nb (subgap currents).

W e have fabricated A l/A lo $_{\rm x}$ /N b/A lo $_{\rm x}$ /A lsingle electron transistors using a lithographic technique described elsewhere.⁵ M easurem ents were done using a sm all dilution refrigerator equipped with well-therm alized and electrically litered measuring lines. The superconducting gaps obtained for N b and A l ($_{\rm N\,b}$ = 1.4 m V, $_{\rm A\,l}$ = 0.2 m eV), and also the measured critical temperatures for N b (T_{C,Nb} 8.0 8.5 K), show that the lm s are indeed of good quality.

At voltages below the gap of Nb, a series of gatedependent resonance peaks appears in the IV characteristics of the SET (Fig. 1). We interpret this as resonant tunneling of C ooper pairs, a transport phenom enon rst predicted theoretically and later observed in Al sym metrically-biased superconducting SETs.⁶ Below we describe the same process for our Nb-island SETs under the asym metric bias shown in Fig. 1. We consider a generic process in which a charge q tunnels through the left junction and a charge q tunnels through the second junction, both into the island. During the process, a charge q = q + q is transferred into the island and a charge Q = q q is transferred through the external circuit in the forward direction. The change in the electrostatic free energy (including work done by the sources) associated with this process is

$$E (q; Q) = \frac{(q)^{2}}{2C} + \frac{q}{C} (q_{0} C_{q}V_{q}) + \frac{q}{C} C_{q} C_{q} \frac{C_{2} C_{1}}{2} V \frac{Q}{2} V; (1)$$

where q_0 is the initial charge of the island, C_1 and C_2 are the capacitances of the left and right junctions, C_g is the gate capacitance, and $C = C_1 + C_2 + C_g$. Resonant C ooper pair tunneling in superconducting SETs occurs when no energy is required for processes resulting in the transport of m C ooper pairs Q = 2m e through the external circuit and the creation of an excess of n C ooper pairs q = 2n on the island, i.e., E (2ne; 2me) = 0.

The dom inant processes are those involving m = 1 and n = 1, corresponding to a single Cooper pair tunneling through either one of the junctions.⁶ For these processes, the resonant condition describes two lattices with a cell size of (4e=C) (2e=C_q) (in V V_q plane) corresponding to odd and even values of $q_0 = e_1$ and displaced with respect to each other by 2e=C along the V axis and by $e=C_{\alpha}$ along the the V_{α} axis. During the time of an experiment, q_0 can either be xed, in which case only one lattice pattern will appear, or it can uctuate between odd and even values, in which case what will be measured is the overlap between the two lattices, resulting in a checkerboard lattice with half the periodicity. This last situation occurs indeed in all of our three samples. To check this, we rst measured the gate modulation at voltages above the quasiparticle threshold of Nb, where the transport is of single-electron type, and determ ined $e=C_{a}$. This corresponds to the size of the checkerboard pattern along V_{q} that we see in our measurem ents at lower bias as well, e.g., $e=C_g = 12:3 \text{ mV}$ ($C_g = 12:9 \text{ aF}$) for the sample of Fig. 1. (For clarity, we will concentrate our discussion on that particular sample from now on. The other two sam ples yielded sim ilar results.) The observation that the checkerboard pattern is 1e-periodic allows us to determ ine e=C = 68:3 V and thus the charging energy $E_c = e^2 = 2C = 34:1$ eV.⁷ The SET's junction

asymmetry is receted in the dierent absolute values of the positive-slope lines (for which n and m have dierent signs) versus the negative-slope lines (m and n have the same sign), yielding $C_1 = 1.03$ fF and $C_2 = 1.29$ fF.

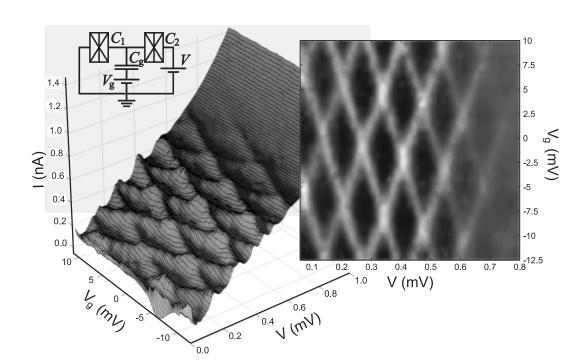


FIG.1: Schem atic of the circuit (upper left inset) and current versus bias and gate voltages (3D plot), showing the checkerboard pattern (right inset) associated with resonant tunneling of Cooper pairs. The contour plot of the right inset is obtained by subtracting the background current thus leaving only the characteristics of the resonant tunneling.

To check for consistency, we have determ ined E_C also by standard C oulom b-blockade therm on etry⁸ with the superconductivity both in Al and Nb suppressed. We nd E_C = 36 eV, which is in very close agreem ent with the results above.

The second intriguing feature in the low-bias IV of our Nb-island SETs, is the presence of relatively large subgap currents: from gures 1 and 2 (a) one can see that the C ooper pair resonances appear as being built upon a current which increases with bias voltage (at voltages larger than 2 $_{A1}$ + 2 $_{Nb}$, it will merge into the quasiparticle current). The origin of the subgap currents in superconductors is still a matter of intense theoretical and experimental investigations.⁹ Here, we further explore these currents by using a magnetic eld to suppress the gap of A l; the transition to the norm alm etal state in the leads is clearly indicated by the disappearance of the Josephson e ect and of the Cooper pair resonances as seen in Fig.2(a).

W hile A lis in the norm al state, a very interesting feature appears at low bias voltages [Fig.2(b)], where we observe a dip in the conductance. In measurements on single A HN b junctions [again with the gap of A l suppressed, Fig.2(b) inset] this feature is not present.⁵ Instead, below 0.2 mV the IV is approximately ohm ic. This shows that the dip is due to the Coulomb blockade of the subgap current, and that in the rst approximation one could attempt to t the graph with the standard analytical expressions for C oulom b-blockade therm om etry⁸ (CBT) [Fig. 2(b), main graph, red dashed line]. Fitting yields 98 mK, which agrees well with the value measured Т using a calibrated resistor therm ally anchored to the mix-13 eV, which is in reasoning chamber, and $E_{\rm C}$ able agreem ent with the value determ ined from Cooper pair resonances, considering that we are not in the lim it $E_{\,\rm C}\,$ and therefore the standard approximations k_B T of C oulom b blockade therm om etry are not accurate, especially for determ in ing E_{c} .

A betterm odel should take into account that we are at low tem peratures $k_B T < E_C$ and also describe the nonlinear increase in the subgap current at higher voltages. To develop such a model, we introduce a lifetim e broadening of the quasiparticle energies, resulting in a density of

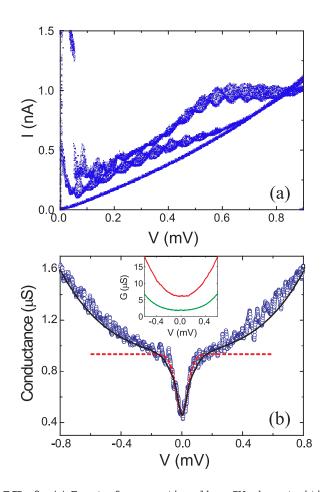


FIG.2: (a) E ect of a magnetic eld on IV characteristics (current values at di erent V_g 's, show ing gate modulation, are superposed): zero, upper curve; interm ediate value, middle curve; com plete suppression of the gap of A l, lower curve. (b) The main graph shows the low-bias C oulom b blockade dip: experim ental values (blue), standard BCS C oulom b-blockade therm om etry t (red dotted line), and the predictions of the orthodox theory with lifetim e broadening and gap inhom ogeneity (black continuous line). The upper inset shows the conductances for two single A HN b junctions of norm al resistances 30 k (lower curve) and 11 k (upper curve).

states¹⁰

$$(E; N_{b}) = Re \frac{E i}{(E i)^{2} \frac{2}{N_{b}}}$$
 : (2)

Thise ect could be caused by the proximity to them etalinsulator transition, due to the granular structure of the Nb lms (with our lms being still on the metalic side, Nb).¹⁰ A nother possibility is the opening of con-

duction channels in the junctions,⁷ as suggested by the relatively large value of the room temperature conductance [for the sample presented in Fig. 1, Fig. 2, and Fig. 3 (a), this was 30 S]. Inrespective to the microscopic origin, this density of states accounts well for the existence of subgap currents seen in Fig. 2 (b), inset. At low energies E Nb the density of states can be approximated as (E; Nb) = Nb + (3 = 2) (E = Nb)².

In the case of a single junction of resistance R with a norm al-state m etal this results in a subgap conductance R ¹ (V; Nb); therefore, ohm ic for low enough voltages and increasing as V² for relatively larger voltages. In addition, the granular structure of the lm s and, possibly, impurities resulting from outgassing of the mask polymer is also making the lm inhomogenous. As a result, the gap edge is sm eared due to local uctuations in the e ective electron-electron interaction. O ther fabrication techniques [e.g. the use of stronger polymers such as PES¹¹] could improve the quality of the Nb lm s. For our sam ples, since the superconducting coherence length in bulk Nb is only $_{Nb}$ = 38 nm, we expect to be in the lim it in which the size of the inhom ogeneities is much larger than $_{\rm Nb}$. In this case, it has been show n^{12} that the e ective (average) density of states takes the form

$$(E) = d_{\rm Nb} P (_{\rm Nb}) (E;_{\rm Nb});$$
 (3)

where P is the probability density associated with a certain value of the gap. For small levels of inhom ogeneity, the function P is a Gaussian of standard distribution centered around an average gap value (slightly smaller than the bulk value).

Finally, to complete our model, we calculate num erically the currents and conductances for the superconducting SET in the fram ework of the orthodox theory of sequential tunneling, by computing the tunneling probabilities into and out of the island (with the density of states above for Nb) and by solving the master equation for the charge on the island. In the case of suppressed Algap, a very good t is obtained for = 0.38 m eV, = 37.5 eV, T = 95.7 mK, and charging energy, E_C = 34.1 eV, as determined before Fig. 2 (b), m ain graph, black continuous line]. The temperature also agrees well with the value obtained by sim pleCBT tting above and the value of the therm on eter.

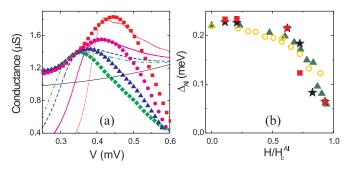


FIG.3: (a) Q ualitative com parison between the conductances extracted from the data by averaging out the gate m odulation (sym bols) and those obtained by num erical simulations (lines) at di erent m agnetic elds. (b) The gap of Alleads (open circle), m easured separately, plotted together with the Algaps determ ined from the conductance peaks of (a) for three SET sam ples (square, triangle, and star).

In the case when the leads are superconducting the com parison with the experim ental data can be done only

qualitatively: the main reason is the existence of C ooper pair resonances peaks, yielding an extra contribution to the current which cannot be elim inated in a straightforward way. However, a num ber of qualitative features can still be observed by averaging the resonance peaks over gate voltages. The conductances obtained by this procedure should re ect the voltage dependence of the subgap current in the region where the height of the resonance peaks is approxim ately constant. A reasonably fair qualitative agreem ent with the model presented above is obtained [Fig. 3(a)]. The main feature that we see both in the calculated conductivities and in the conductivities obtained from our data through the above procedure is the appearance of a peak at the onset of the Alquasiparticle threshold (2 $_{\rm Al}$). By using a magnetic eld to partially suppress the gap of A l, we see that the peak moves to the left [see Fig. 2 (a) and Fig. 3 (a)]. To verify that this is indeed the case, we have measured single A -Aljunctions with the same fabrication parameters as the leads of the Nb-island SET, and determ ined the gap of Al at various m agnetic elds [Fig. 3(b), circles]. The agreem ent with the gaps determ ined from the low -voltage features [Fig. 3 (a)] of three Nb-island SET samples (square,

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triangle, star) is good.

In conclusion, we have fabricated and measured superconducting single-electron transistors and we have presented evidence for a number of transport processes occurring at bias voltages below the gap of the island: resonant tunneling of C coper pairs, C oulom b blockade of the subgap current for norm alleads, and the appearance of a step in the subgap current at 2 $_{A1}$ for the case of superconducting leads.

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